Make ideas real



R&S®RT-ZHD HIGH VOLTAGE DIFF. PROBE FAMILY versus Keysight DP0001A



The R&S®RT-ZHD family outperforms the Keysight DP0001A probe with low noise and exceptional high linearity, enabling precise high voltage measurements

To achieve the maximum power efficiency and power densities in switched-mode power supplies, switching loss has to be minimized. This requires the use of modern, fast-switching semiconductors. The R&S®RT-ZHD high voltage differential probes offer a bandwidth of up to 200 MHz and an excellent common mode rejection ratio (CMRR) over a broad frequency range, making them ideal for measurements on fast-switching power electronics. Extraordinarily low added noise results in high-quality measurements.

Your benefit	Features
2000 V offset capability with maximum vertical sensitivity	Due to their integrated offset circuit, the R&S®RT-ZHD probes offer an offset voltage range that is independent of the vertical setting of the oscilloscope and the attenuation factor of the probe. The smallest ripple voltages can be measured on large DC link voltages without compromising sensitivity.
Excellent functions	Automatic range adjustment, overrange signaling, integrated DC voltmeter
Accurate results	Accurate, low inherent noise, high bandwidth and slew rate, high linearity, very low drift, high CMRR

Parameter	R&S®RT- ZHD07	R&S®RT- ZHD15	R&S®RT- ZHD16	R&S®RT- ZHD60	Keysight DP0001A		
Specifications	Specifications						
Input voltage	750 V	1500 V		6000 V	200 V, 400 V, 1000 V, 2000 V (depending on attenuation setting)		
Bandwidth	200 MHz	100 MHz	200 MHz	100 MHz	300 MHz to 400 MHz (bandwidth limits input voltage)		
Interface	Rohde & Schwar	z probe interface	AutoProbe				
Input to ground	300 V CAT III	II 1000 V CAT III			1000 V CAT III		
Attenuation	25:1 250:1	50:1 500:1		100:1 1000:1	50:1, 100:1 250:1, 500:1		
Noise (mV (RMS))	12 mV	20 mV	25 mV	70 mV	180 mV (50:1, 100:1) 280 mV (250:1) 300 mV (500:1)		
DC accuracy	0.5 %				0.7 %		
Drift	very low				-		
Common mode rejecti	Common mode rejection ratio (CMRR)						
DC to 60 Hz	> 80 dB (meas.)				> 80 dB		
to 1 MHz	60 dB (meas.)				60 dB		
to 5 MHz	55 dB (meas.)				50 dB		
to 100 MHz	30 dB (meas.)				32 dB		
Additional functionality							
Additional offset compensation	±1000 V	±2000 V			-		
DC voltmeter	integrated				-		
R&S®ProbeMeter measurement error	< 0.1 %			< 0.12 %	-		



Noise performance



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The R&S®RT-ZHD features a low-noise design. Extraordinarily low added noise results in high-quality measurements. The Keysight DP0001A probe has up to 12 times more noise than the R&S®RT-ZHD. High noise reduces the accuracy of measurements and makes it difficult to see small details and trigger on them.

Zero error comparison



The R&S®RT-ZHD probes stand out with small zero error, which ensures minimal variation in measurements and increases confidence in your results.

The Keysight DP0001A exhibit very low linearity and high zero error. This means a very high susceptibility to errors, the degree of which increases dramatically with time.



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